BF2030...

## Silicon N-Channel MOSFET Tetrode

- For low noise, high gain controlled input stages up to 1 GHz
- Operating voltage 5V
- Pb-free (RoHS compliant) package ${ }^{1)}$
- Qualified according AEC Q101


RoHS


ESD (Electrostatic discharge) sensitive device, observe handling precaution!
Class 2 (2000V-4000V) pin to pin Human Body Model

| Type | Package | Pin Configuration |  |  |  |  |  | Marking |
| :--- | :--- | :--- | :--- | :--- | :--- | :--- | :--- | :--- |
| BF2030 | SOT143 | 1= S | $2=\mathrm{D}$ | $3=\mathrm{G} 2$ | $4=\mathrm{G} 1$ | - | - | NDs |
| BF2030R | SOT143R | 1= D | 2=S | $3=\mathrm{G} 1$ | $4=\mathrm{G} 2$ | - | - | NDs |
| BF2030W | SOT343 | 1= | 2=S | $3=\mathrm{G} 1$ | $4=\mathrm{G} 2$ | - | - | NDs |

## Maximum Ratings

| Parameter | Symbol | Value | Unit |
| :--- | :--- | :---: | :--- |
| Drain-source voltage | $V_{\mathrm{DS}}$ | 8 | V |
| Continuous drain current | $\mathrm{I}_{\mathrm{D}}$ | 40 | mA |
| Gate 1/ gate 2-source current | $\pm I_{\mathrm{G} 1 / 2 \mathrm{SM}}$ | 10 |  |
| Gate 1 (external biasing) | $+V_{\mathrm{G} 1 \mathrm{SE}}$ | 6 | V |
| Total power dissipation | $P_{\text {tot }}$ |  | mW |
| $T_{\mathrm{S}} \leq 76^{\circ} \mathrm{C}, \mathrm{BF} 2030, \mathrm{BF2030R}$ |  | 200 |  |
| $T_{\mathrm{S}} \leq 94^{\circ} \mathrm{C}, \mathrm{BF} 2030 \mathrm{~W}$ |  | 200 |  |
| Storage temperature |  | $T_{\text {stg }}$ | $-55 \ldots 150$ |
| Channel temperature | $T_{\mathrm{ch}}$ | ${ }^{\circ} \mathrm{C}$ |  |

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## Thermal Resistance

| Parameter | Symbol | Value | Unit |
| :--- | :--- | :--- | :--- |
| Channel - soldering point ${ }^{1)}$ | $R_{\text {thchs }}$ |  | K/W |
| BF2030/ BF2030R |  | $\leq 370$ |  |
| BF2030W |  | $\leq 280$ |  |

Electrical Characteristics at $T_{\mathrm{A}}=25^{\circ} \mathrm{C}$, unless otherwise specified

| Parameter | Symbol | Values |  |  | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | min. | typ. | max. |  |
| DC Characteristics |  |  |  |  |  |
| Drain-source breakdown voltage $I_{\mathrm{D}}=20 \mu \mathrm{~A}, V_{\mathrm{G} 1 \mathrm{~S}}=0, V_{\mathrm{G} 2 \mathrm{~S}}=0$ | $V_{(\mathrm{BR}) \mathrm{DS}}$ | 10 | - | - | V |
| Gate1-source breakdown voltage $+l_{\mathrm{G} 1 \mathrm{~S}}=10 \mathrm{~mA}, V_{\mathrm{G} 2 \mathrm{~S}}=0, V_{\mathrm{DS}}=0$ | $+V_{(B R) G 1 S S}$ | 6 | - | 15 |  |
| Gate2-source breakdown voltage $+I_{\mathrm{G} 2 \mathrm{~S}}=10 \mathrm{~mA}, V_{\mathrm{G} 1 \mathrm{~S}}=0, V_{\mathrm{DS}}=0$ | $+V_{(B R) G 2 S S}$ | 6 | - | 15 |  |
| Gate1-source leakage current $V_{\mathrm{G} 1 \mathrm{~S}}=5 \mathrm{~V}, V_{\mathrm{G} 2 \mathrm{~S}}=0, V_{\mathrm{DS}}=0$ | $+l_{\text {G1SS }}$ | - | - | 50 | nA |
| Gate2-source leakage current $V_{\mathrm{G} 2 \mathrm{~S}}=5 \mathrm{~V}, V_{\mathrm{G} 1 \mathrm{~S}}=0, V_{\mathrm{DS}}=0$ | $+I_{\text {G2S }}$ | - | - | 50 |  |
| Drain current $V_{\mathrm{DS}}=5 \mathrm{~V}, V_{\mathrm{G} 1 \mathrm{~S}}=0, V_{\mathrm{G} 2 \mathrm{~S}}=4 \mathrm{~V}$ | IDSS | - | - | 50 | $\mu \mathrm{A}$ |
| Drain-source current $V_{\mathrm{DS}}=5 \mathrm{~V}, V_{\mathrm{G} 2 \mathrm{~S}}=4 \mathrm{~V}, R_{\mathrm{G} 1}=100 \mathrm{k} \Omega$ | IDSX | - | 12 | - | mA |
| Gate1-source pinch-off voltage $V_{\mathrm{DS}}=5 \mathrm{~V}, V_{\mathrm{G} 2 S}=4 \mathrm{~V}, I_{\mathrm{D}}=20 \mu \mathrm{~A}$ | $V_{\mathrm{G1S}(\mathrm{p})}$ | 0.3 | 0.5 | - | V |
| Gate2-source pinch-off voltage $V_{D S}=5 \mathrm{~V}, I_{D}=20 \mu \mathrm{~A}$ | $V_{\mathrm{G} 2 \mathrm{~S}(\mathrm{p})}$ | 0.3 | 0.6 | - |  |

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Electrical Characteristics at $T_{\mathrm{A}}=25^{\circ} \mathrm{C}$, unless otherwise specified

| Parameter | Symbol | Values |  |  | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | min. | typ. | max. |  |
| AC Characteristics (verified by random sampling) |  |  |  |  |  |
| Forward transconductance $V_{\mathrm{DS}}=5 \mathrm{~V}, I_{\mathrm{D}}=10 \mathrm{~mA}, V_{\mathrm{G} 2 \mathrm{~S}}=4 \mathrm{~V}$ | $g_{\text {fs }}$ | 27 | 31 | - | mS |
| Gate1 input capacitance $\begin{aligned} & V_{\mathrm{DS}}=5 \mathrm{~V}, I_{\mathrm{D}}=10 \mathrm{~mA}, V_{\mathrm{G} 2 \mathrm{~S}}=4 \mathrm{~V}, \\ & f=10 \mathrm{MHz} \end{aligned}$ | $C_{\text {g1ss }}$ | - | 2.4 | 2.8 | pF |
| Output capacitance $\begin{aligned} & V_{\mathrm{DS}}=5 \mathrm{~V}, I_{\mathrm{D}}=10 \mathrm{~mA}, V_{\mathrm{G} 2 \mathrm{~S}}=4 \mathrm{~V}, \\ & f=10 \mathrm{MHz} \end{aligned}$ | $C_{\text {dss }}$ | - | 1.3 | - |  |
| Power gain $\begin{aligned} & V_{\mathrm{DS}}=5 \mathrm{~V}, I_{\mathrm{D}}=10 \mathrm{~mA}, V_{\mathrm{G} 2 \mathrm{~S}}=4 \mathrm{~V}, \\ & f=800 \mathrm{MHz} \end{aligned}$ | $G_{p}$ | 20 | 23 | - | dB |
| Noise figure $\begin{aligned} & V_{\mathrm{DS}}=5 \mathrm{~V}, I_{\mathrm{D}}=10 \mathrm{~mA}, V_{\mathrm{G} 2 \mathrm{~S}}=4 \mathrm{~V}, \\ & f=800 \mathrm{MHz} \end{aligned}$ | F | - | 1.5 | 2.2 | dB |
| Gain control range $V_{\mathrm{DS}}=5 \mathrm{~V}, V_{\mathrm{G} 2 \mathrm{~S}}=4 \ldots 0 \mathrm{~V}, f=800 \mathrm{MHz}$ | $\Delta G_{p}$ | 40 | 50 | - |  |

Total power dissipation $P_{\text {tot }}=f\left(T_{\mathrm{S}}\right)$ BF2030, BF2030R


Drain current $I_{\mathrm{D}}=f\left(I_{\mathrm{G} 1}\right)$
$V_{\mathrm{G} 2 \mathrm{~S}}=4 \mathrm{~V}$


Total power dissipation $P_{\text {tot }}=f\left(T_{\mathrm{S}}\right)$ BF2030W


Output characteristics $\mathbf{I}_{\mathrm{D}}=f\left(V_{\mathrm{DS}}\right)$
$V_{G 2 S}=4 \mathrm{~V}$
$V_{\mathrm{G} 1 \mathrm{~S}}=$ Parameter


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Gate 1 current $I_{\mathrm{G} 1}=f\left(\mathrm{~V}_{\mathrm{G} 1 \mathrm{~S}}\right)$
$V_{D S}=5 \mathrm{~V}$
$V_{\mathrm{G} 2 \mathrm{~S}}=$ Parameter


Drain current $/ \mathrm{D}=f\left(V_{\mathrm{G} 1 \mathrm{~S}}\right)$
$V_{\mathrm{DS}}=5 \mathrm{~V}$
$V_{\mathrm{G} 2 \mathrm{~S}}=$ Parameter


Gate 1 forward transconductance
$g_{\mathrm{fs}}=f\left(l_{\mathrm{D}}\right)$
$V_{\mathrm{DS}}=5 \mathrm{~V}, V_{\mathrm{G} 2 \mathrm{~S}}=$ Parameter


Drain current $/ \mathrm{D}=f\left(V_{G G}\right)$
$V_{\mathrm{DS}}=5 \mathrm{~V}, V_{\mathrm{G} 2 \mathrm{~S}}=4 \mathrm{~V}, R_{\mathrm{G} 1}=100 \mathrm{k} \Omega$ (connected to $V_{\mathrm{GG}}, V_{\mathrm{GG}}=$ gate1 supply voltage)


Drain current $l_{\mathrm{D}}=f\left(V_{G G}\right)$
$V_{\mathrm{G} 2 \mathrm{~S}}=4 \mathrm{~V}$
$R_{\mathrm{G} 1}=$ Parameter in $\mathrm{k} \Omega$


Crossmodulation $V_{\text {unw }}=(A G C)$
$V_{D S}=5 \mathrm{~V}$


Cossmodulation test circuit


Package Outline


Foot Print


Marking Layout (Example)


Standard Packing
Reel $\varnothing 180 \mathrm{~mm}=3.000$ Pieces/Reel
Reel $\varnothing 330 \mathrm{~mm}=10.000$ Pieces/Reel


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[^0]:    ${ }^{1} \mathrm{~Pb}$-containing package may be available upon special request

[^1]:    ${ }^{1}$ For calculation of $R_{\text {thJA }}$ please refer to Application Note Thermal Resistance

